

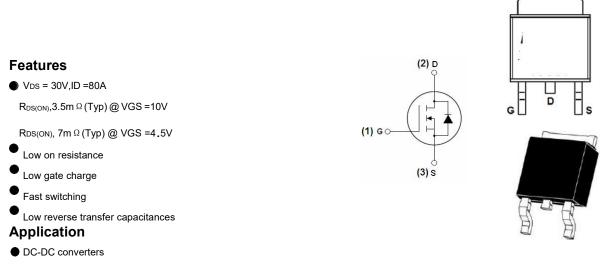
Product data sheet

www.msksemi.com



MS80N03 Semiconductor

Schematic diagram



• Synchronous Rectifier



Absolute Maximum Ratings(TA=25℃ unless otherwise noted)

| Parameter | | Symbol | Value | Unit |
|---|------------------|------------------|-------------|------|
| Drain-Source Voltage | | V _{DS} | 30 | V |
| Gate-Source Voltage | | V _{GS} | ±20 | V |
| TC=25°C | | | 80 | Α |
| Drain Current-Continuous ^{Note3} | TC=100℃ | – I _D | 63 | Α |
| Drain Current-Pulsed ^{Note1} | I _{DM} | 200 | Α | |
| Avalanche Energy ^{Note4} | | E _{AS} | 280 | mJ |
| Avalanche Current | | I _{AS} | 33 | Α |
| Maximum Power Dissipation TC=25°C | | PD | 105 | W |
| Storage Temperature Range | T _{STG} | -55 to +150 | °C | |
| Operating Junction Temperature Range | | TJ | -55 to +150 | °C |

Thermal Resistance

| Parameter | Symbol | Min. | Тур. | Max | Unit |
|-------------------------------------|--------|------|------|-----|------|
| Thermal Resistance,Junction-to-Case | Rejc | - | 3.3 | - | °C/W |



Electrical Characteristics(TJ=25°C unless otherwise noted)

| OFF CHARACTERISTICS | | | | | | |
|---------------------------------|-------------------|--|------|------|------|------|
| Parameter | Symbol | Conditions | Min. | Тур. | Max. | Unit |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V,I _{DS} =250uA | 30 | - | - | V |
| Zero Gate Voltage Drain Current | IDSS | V _{DS} =30V,V _{GS} =0V | - | - | 1 | uA |
| Gate-Body Leakage | I _{GSS} | V _{GS} =±20V,V _{DS} =0V | - | - | ±100 | nA |

| ON CHARACTERISTICS | | | | | | |
|----------------------------------|---------|--|------|------|------|------------|
| Parameter | Symbol | Conditions | Min. | Тур. | Max. | Unit |
| Gate Threshold Voltage | VGS(TH) | $V_{DS}=V_{GS}$, $I_{DS}=250$ uA | 1.0 | 1.7 | 2.5 | V |
| Drain-Source On-State Resistance | RDS(ON) | V_{GS} =10V, I_{DS} =30A | - | 3.5 | 5.5 | m Ω |
| | | V _{GS} =4.5V,I _{DS} =20A | - | 7 | 8.9 | |

| DYNAMIC CHARACTERISTICS | | | | | | |
|------------------------------|------------------|-------------------------------|------|------|------|------|
| Parameter | Symbol | Conditions | Min. | Тур. | Max. | Unit |
| Input Capacitance | Ciss | | - | 1963 | - | |
| Output Capacitance | Coss | VDS =15V, VGS = 0V, f=1MHz | - | 248 | - | pF |
| Reverse Transfer Capacitance | C _{rss} | I=IMH2 | - | 221 | - | |
| Gate Resisitance | Da | VDD=0V,VGS=1V, | | 1.43 | | Ω |
| | Rg | F=1MHz | - | 1.43 | - | 52 |

| SWITCHING CHARACTERISTICS | | | | | | | |
|-----------------------------|---------------------|--|------|------|------|------|--|
| Parameter | Symbol | Conditions | Min. | Тур. | Max. | Unit | |
| Turn-On Delay Time | T _{d(on)} | | - | 55 | - | | |
| Rise Time | tr | V_{GS} =10V, V_{DS} =15V, | - | 36.4 | - | | |
| Turn-Off Delay Time | T _{d(off)} | $R_{GEN}=3\Omega I_D=20A$ | - | 37.5 | - | ns | |
| Fall Time | t _f | | - | 14 | - | | |
| Total Gate Charge at 10V | Qg | | - | 41 | - | | |
| Gate to Source Gate Charge | Q _{gs} | V _{DS} =15V,I _{DS} =45A, V _{GS} =10V | - | 6.4 | - | nC | |
| Gate to Drain"Miller"Charge | Q _{gd} | VGS=10V | - | 11 | - | 1 | |

| DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS | | | | | | | |
|--|-----------------|--|------|------|------|------|--|
| Parameter | Symbol | Conditions | Min. | Тур. | Max. | Unit | |
| Drain-Source Diode Forward Voltage | V _{SD} | V _{GS} =0V,I _{DS} =20A | - | - | 1.2 | V | |
| Reverse Recovery Time | trr | TJ=25℃,IF=20A | - | 21.7 | - | nS | |
| Reverse Recovery Charge | Qrr | di/dt=100A/us | - | 7.2 | - | nC | |

Notes:

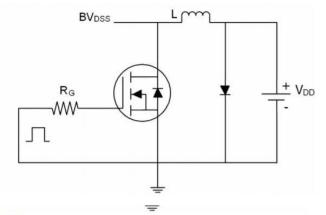
- 1: Repetitive rating, pulse width limited by maximum junction temperature.
- 2: Surface mounted on FR4 Board, t≤10sec.
- 3: Pulse width \leq 300µs, duty cycle \leq 2%.
- 4: EAS condition: L=0.5mH,VDD=15V,VG=10V,V_{GATE}=30V,Start TJ=25 $^\circ\!\mathrm{C}.$



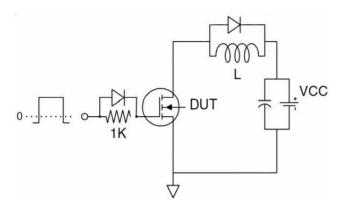


Test Circuit

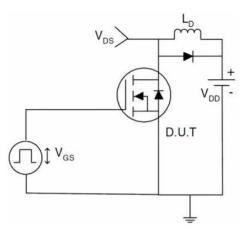
1) EAS Test Circuit



2) Gate Charge Test Circuit

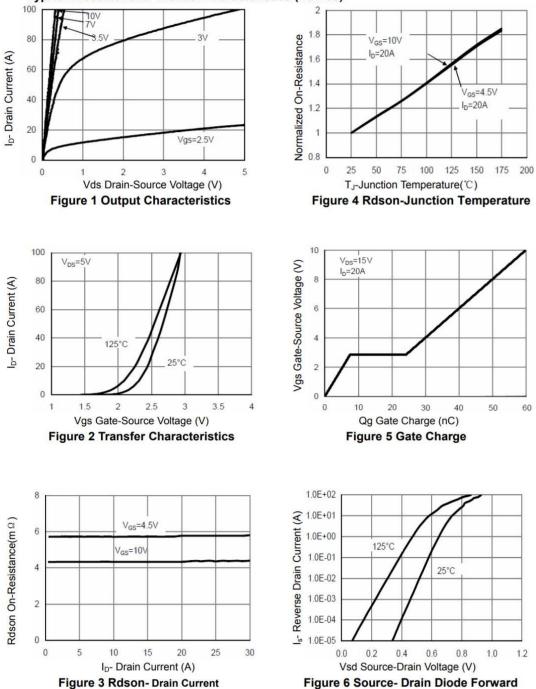


3) Switch Time Test Circuit





Typical Electrical and Thermal Characteristics (Curves)





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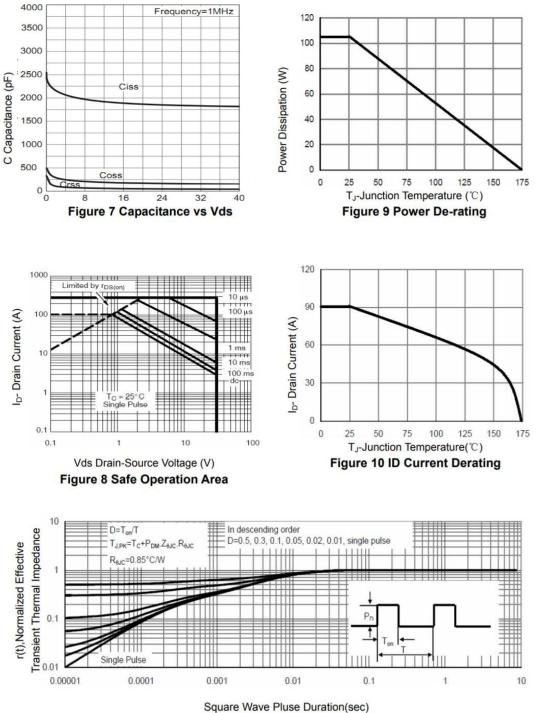
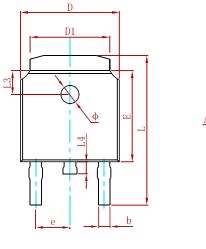


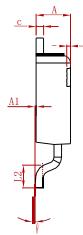
Figure 11 Normalized Maximum Transient Thermal Impedance



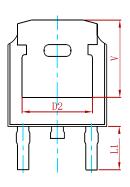


PACKAGE MECHANICAL DATA



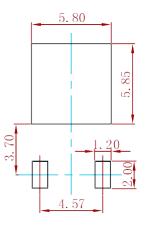


h



| 0. milest | Dimensions | In Millimeters | Dimension | s In Inches |
|-----------|------------|----------------|-----------|-------------|
| Symbol | Min. | Max. | Min. | Max. |
| A | 2.200 | 2.400 | 0.087 | 0.094 |
| A1 | 0.000 | 0.127 | 0.000 | 0.005 |
| b | 0.635 | 0.770 | 0.025 | 0.030 |
| C | 0.460 | 0.580 | 0.018 | 0.023 |
| D | 6.500 | 6.700 | 0.256 | 0.264 |
| D1 | 5.100 | 5.460 | 0.201 | 0.215 |
| D2 | 4.830 | REF. | 0.190 | REF. |
| E | 6.000 | 6.200 | 0.236 | 0.244 |
| e | 2.186 | 2.386 | 0.086 | 0.094 |
| L | 9.712 | 10.312 | 0.382 | 0.406 |
| L1 | 2.900 | REF. | 0.114 | REF. |
| L2 | 1.400 | 1.700 | 0.055 | 0.067 |
| L3 | 1.600 | REF. | 0.063 | REF. |
| L4 | 0.600 | 1.000 | 0.024 | 0.039 |
| Φ | 1.100 | 1.300 | 0.043 | 0.051 |
| θ | 0° | 8° | 0° | 8° |
| h | 0.000 | 0.300 | 0.000 | 0.012 |
| V | 5.250 | REF. | 0.207 | REF. |

Suggested Pad Layout



Note:

1.Controlling dimension:in millimeters.

2.General tolerance:± 0.05mm

3. The pad layout is for reference purposes only.

REEL SPECIFICATION

| P/N | PKG | QTY |
|---------|--------|------|
| MS80N03 | TO-252 | 2500 |



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